

- Low  $r_{DS(on)}$  . . . 5  $\Omega$  Typical
- Avalanche Energy . . . 30 mJ
- Eight Power DMOS-Transistor Outputs of 150-mA Continuous Current
- 500-mA Typical Current-Limiting Capability
- Output Clamp Voltage . . . 50 V
- Low Power Consumption

### description

The TPIC6B273 is a monolithic, high-voltage, medium-current, power logic octal D-type latch with DMOS-transistor outputs designed for use in systems that require relatively high load power. The device contains a built-in voltage clamp on the outputs for inductive transient protection. Power driver applications include relays, solenoids, and other medium-current or high-voltage loads.

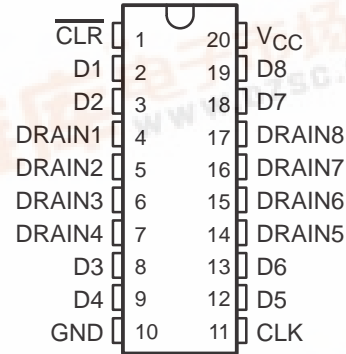
The TPIC6B273 contains eight positive-edge-triggered D-type flip-flops with a direct clear input. Each flip-flop features an open-drain power DMOS-transistor output.

When clear ( $\overline{CLR}$ ) is high, information at the D inputs meeting the setup time requirements is transferred to the DRAIN outputs on the positive-going edge of the clock (CLK) pulse. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going pulse. When the clock input (CLK) is at either the high or low level, the D input signal has no effect at the output. An asynchronous  $\overline{CLR}$  is provided to turn all eight DMOS-transistor outputs off. When data is low for a given output, the DMOS-transistor output is off. When data is high, the DMOS-transistor output has sink-current capability.

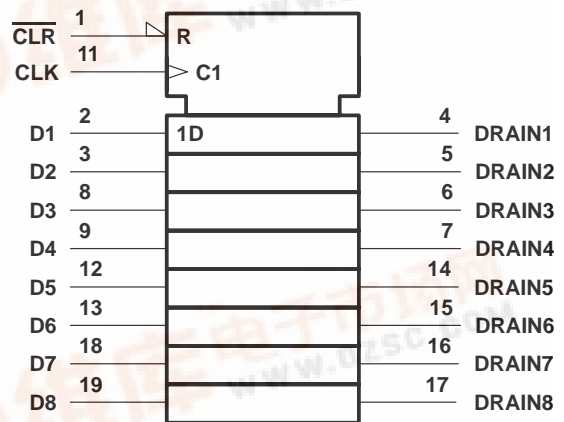
Outputs are low-side, open-drain DMOS transistors with output ratings of 50 V and 150-mA continuous sink-current capability. Each output provides a 500-mA typical current limit at  $T_C = 25^\circ\text{C}$ . The current limit decreases as the junction temperature increases for additional device protection.

The TPIC6B273 is characterized for operation over the operating case temperature range of  $-40^\circ\text{C}$  to  $125^\circ\text{C}$ .

DW OR N PACKAGE  
(TOP VIEW)



### logic symbol



† This symbol is in accordance with ANSI/IEEE Standard 91-1984 and IEC Publication 617-12.

FUNCTION TABLE  
(each channel)

INPUTS			OUTPUT
$\overline{CLR}$	CLK	D	DRAIN
L	X	X	H
H	↑	H	L
H	↑	L	H
H	L	X	Latched

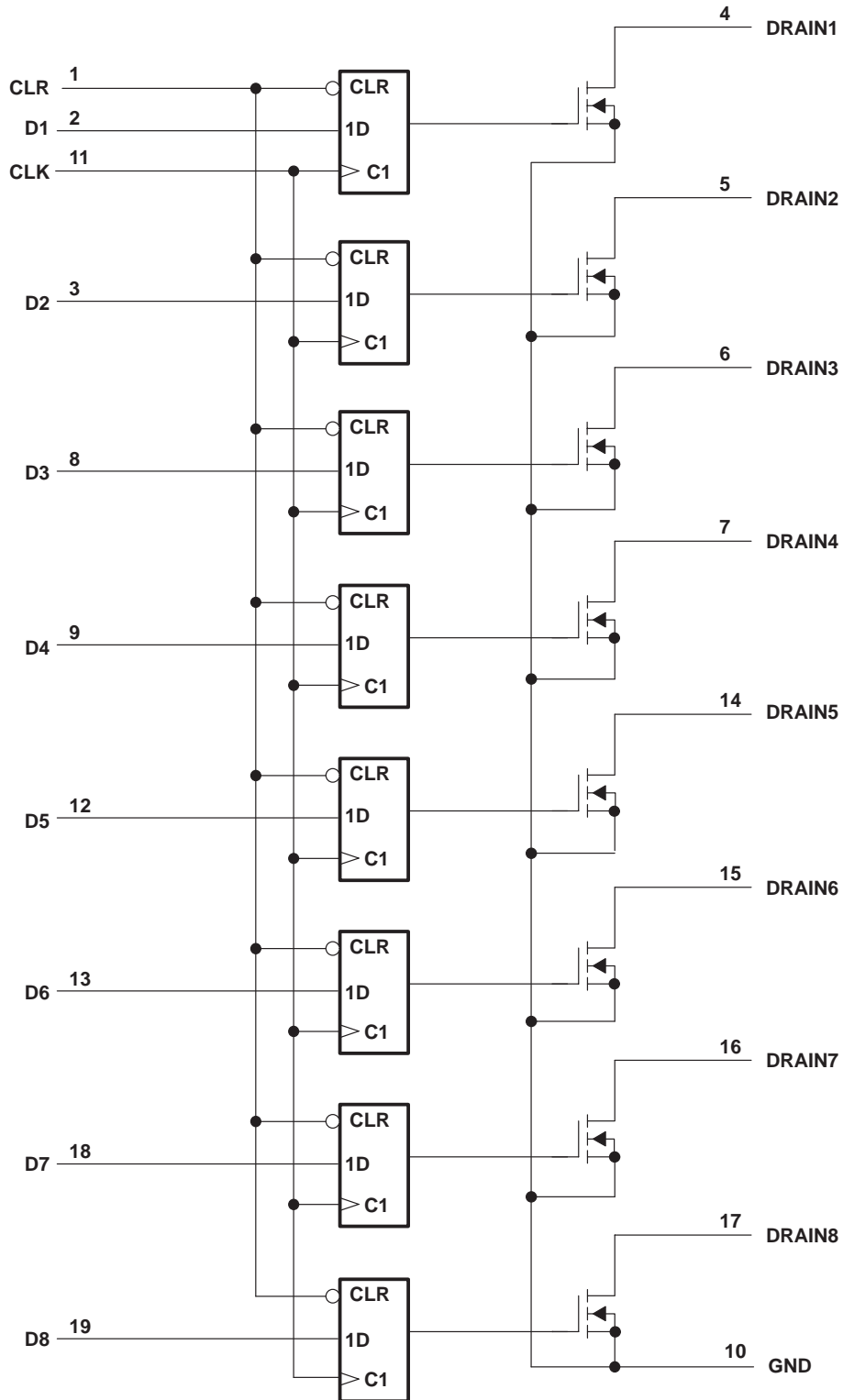
H = high level, L = low level, X = irrelevant



# TPIC6B273 POWER LOGIC OCTAL D-TYPE LATCH

SLIS031 – APRIL 1994 – REVISED JULY 1995

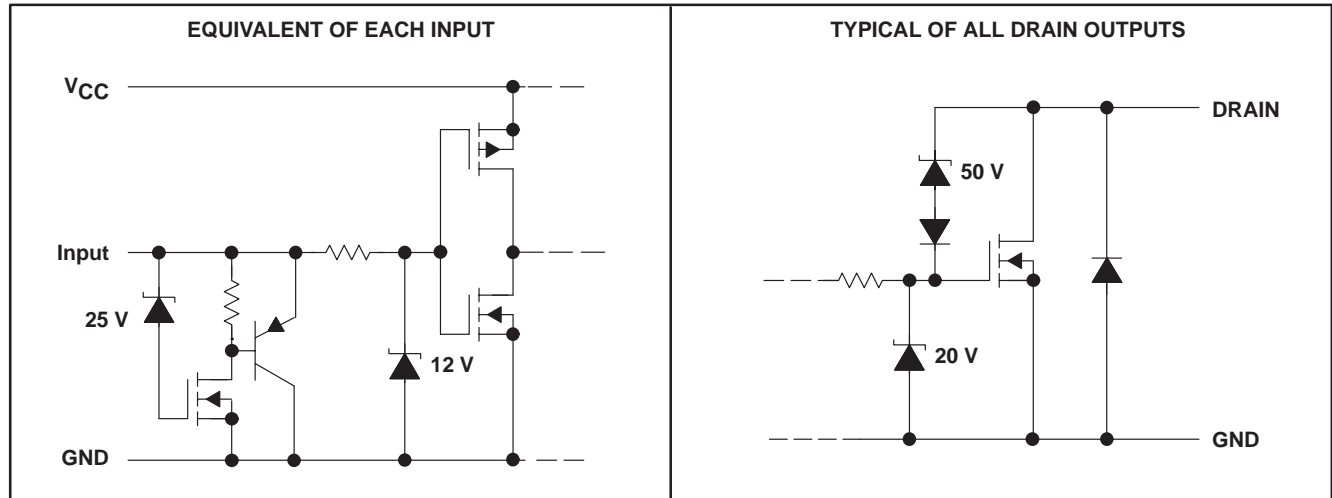
## logic diagram (positive logic)



# TPIC6B273 POWER LOGIC OCTAL D-TYPE LATCH

SLIS031 – APRIL 1994 – REVISED JULY 1995

## schematic of inputs and outputs



## absolute maximum ratings over recommended operating case temperature range (unless otherwise noted)†

Logic supply voltage, $V_{CC}$ (see Note 1)	7 V
Logic input voltage range, $V_I$	-0.3 V to 7 V
Power DMOS drain-to-source voltage, $V_{DS}$ (see Note 2)	50 V
Continuous source-to-drain diode anode current	500 mA
Pulsed source-to-drain diode anode current (see Note 3)	1 A
Pulsed drain current, each output, all outputs on, $I_D, T_C = 25^\circ\text{C}$ (see Note 3)	500 mA
Continuous drain current, each output, all outputs on, $I_D, T_C = 25^\circ\text{C}$	150 mA
Peak drain current single output, $I_{DM}, T_C = 25^\circ\text{C}$ (see Note 3)	500 mA
Single-pulse avalanche energy, $E_{AS}$ (see Figure 4)	30 mJ
Avalanche current, $I_{AS}$ (see Note 4)	500 mA
Continuous total dissipation	See Dissipation Rating Table
Operating virtual junction temperature range, $T_J$	-40°C to 150°C
Operating case temperature range, $T_C$	-40°C to 125°C
Storage temperature range	-65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES:
- All voltage values are with respect to GND.
  - Each power DMOS source is internally connected to GND.
  - Pulse duration  $\leq 100 \mu\text{s}$  and duty cycle  $\leq 2\%$ .
  - DRAIN supply voltage = 15 V, starting junction temperature ( $T_{JS}$ ) = 25°C,  $L = 200 \text{ mH}$ ,  $I_{AS} = 0.5 \text{ A}$  (see Figure 4).

**DISSIPATION RATING TABLE**

PACKAGE	$T_C \leq 25^\circ\text{C}$ POWER RATING	DERATING FACTOR ABOVE $T_C = 25^\circ\text{C}$	$T_C = 125^\circ\text{C}$ POWER RATING
DW	1389 mW	11.1 mW/°C	278 mW
N	1050 mW	10.5 mW/°C	263 mW

# TPIC6B273

## POWER LOGIC OCTAL D-TYPE LATCH

SLIS031 – APRIL 1994 – REVISED JULY 1995

### recommended operating conditions

	MIN	MAX	UNIT
Logic supply voltage, $V_{CC}$	4.5	5.5	V
High-level input voltage, $V_{IH}$	0.85 $V_{CC}$		V
Low-level input voltage, $V_{IL}$	0.15 $V_{CC}$		V
Pulsed drain output current, $T_C = 25^\circ\text{C}$ , $V_{CC} = 5\text{ V}$ (see Notes 3 and 5)	-500	500	mA
Setup time, D high before $\text{CLK}\uparrow$ , $t_{SU}$ (see Figure 2)	20		ns
Hold time, D high after $\text{CLK}\uparrow$ , $t_H$ (see Figure 2)	20		ns
Pulse duration, $t_W$ (see Figure 2)	40		ns
Operating case temperature, $T_C$	-40	125	$^\circ\text{C}$

### electrical characteristics, $V_{CC} = 5\text{ V}$ , $T_C = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{(BR)DSX}$ Drain-to-source breakdown voltage	$I_D = 1\text{ mA}$	50			V
$V_{SD}$ Source-to-drain diode forward voltage	$I_F = 100\text{ mA}$		0.85	1	V
$I_{IH}$ High-level input current	$V_{CC} = 5.5\text{ V}$ , $V_I = V_{CC}$			1	$\mu\text{A}$
$I_{IL}$ Low-level input current	$V_{CC} = 5.5\text{ V}$ , $V_I = 0$			-1	$\mu\text{A}$
$I_{CC}$ Logic supply current	$V_{CC} = 5.5\text{ V}$	All outputs off	20	100	$\mu\text{A}$
		All outputs on	150	300	
$I_N$ Nominal current	$V_{DS(on)} = 0.5\text{ V}$ , $I_N = I_D$ , $T_C = 85^\circ\text{C}$ , See Notes 5, 6, and 7		90		mA
$I_{DSX}$ Off-state drain current	$V_{DS} = 40\text{ V}$ , $V_{CC} = 5.5\text{ V}$		0.1	5	$\mu\text{A}$
	$V_{DS} = 40\text{ V}$ , $V_{CC} = 5.5\text{ V}$ , $T_C = 125^\circ\text{C}$		0.15	8	
$r_{DS(on)}$ Static drain-to-source on-state resistance	$I_D = 100\text{ mA}$ , $V_{CC} = 4.5\text{ V}$	See Notes 5 and 6 and Figures 6 and 7	4.2	5.7	$\Omega$
	$I_D = 100\text{ mA}$ , $V_{CC} = 4.5\text{ V}$ , $T_C = 125^\circ\text{C}$		6.8	9.5	
	$I_D = 350\text{ mA}$ , $V_{CC} = 4.5\text{ V}$		5.5	8	

### switching characteristics, $V_{CC} = 5\text{ V}$ , $T_C = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{PLH}$ Propagation delay time, low-to-high-level output from CLK	$C_L = 30\text{ pF}$ , $I_D = 100\text{ mA}$ , See Figures 1, 2, and 8		150		ns
$t_{PHL}$ Propagation delay time, high-to-low-level output from CLK			90		ns
$t_r$ Rise time, drain output			200		ns
$t_f$ Fall time, drain output			200		ns
$t_a$ Reverse-recovery-current rise time	$I_F = 100\text{ mA}$ , $di/dt = 20\text{ A}/\mu\text{s}$ , See Notes 5 and 6 and Figure 3		100		ns
$t_{rr}$ Reverse-recovery time			300		

- NOTES: 3. Pulse duration  $\leq 100\ \mu\text{s}$  and duty cycle  $\leq 2\%$ .  
 5. Technique should limit  $T_J - T_C$  to  $10^\circ\text{C}$  maximum.  
 6. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.  
 7. Nominal current is defined for a consistent comparison between devices from different sources. It is the current that produces a voltage drop of 0.5 V at  $T_C = 85^\circ\text{C}$ .

# TPIC6B273 POWER LOGIC OCTAL D-TYPE LATCH

SLIS031 – APRIL 1994 – REVISED JULY 1995

## thermal resistance

PARAMETER		TEST CONDITIONS	MIN	MAX	UNIT
$R_{\theta JA}$	Thermal resistance, junction-to-ambient	DW package		90	°C/W
		N package	All 8 outputs with equal power	95	

## PARAMETER MEASUREMENT INFORMATION

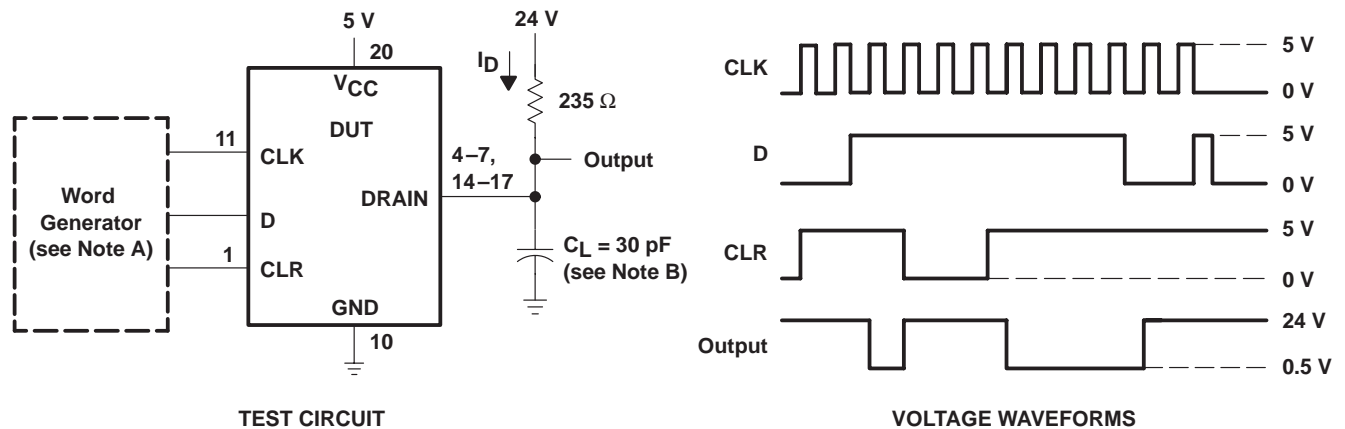


Figure 1. Resistive-Load Test Circuit and Voltage Waveforms

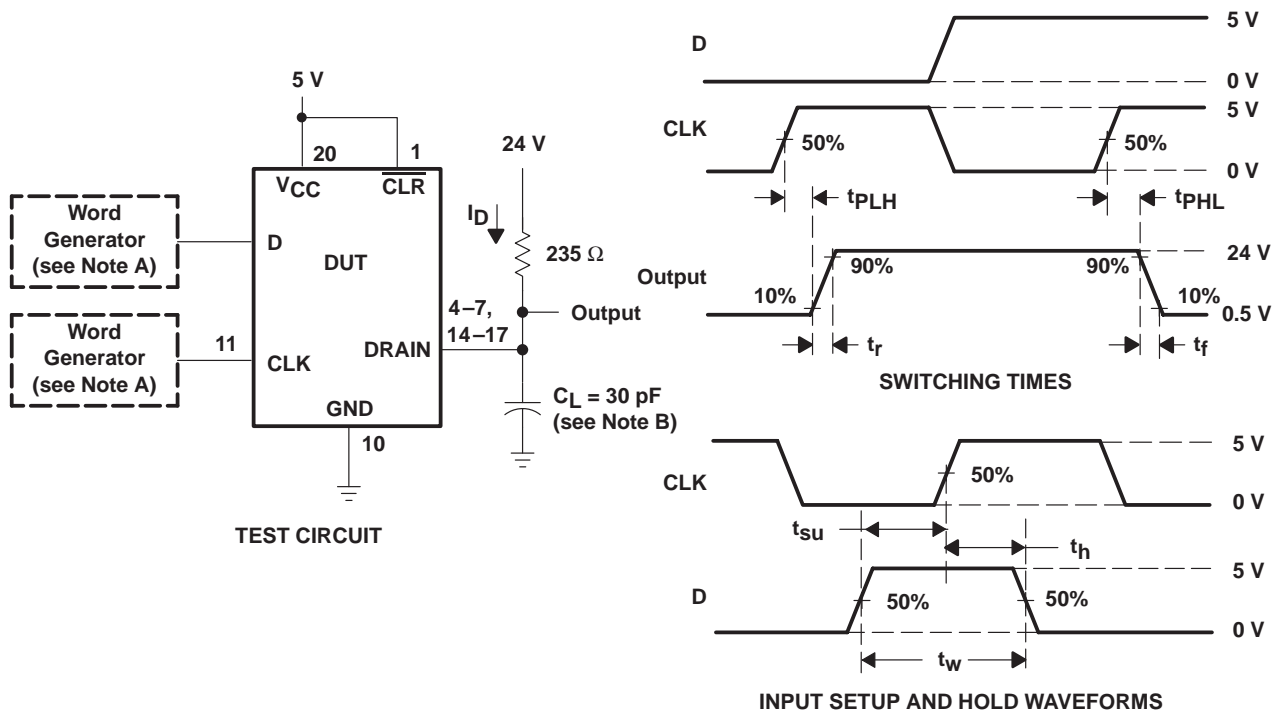


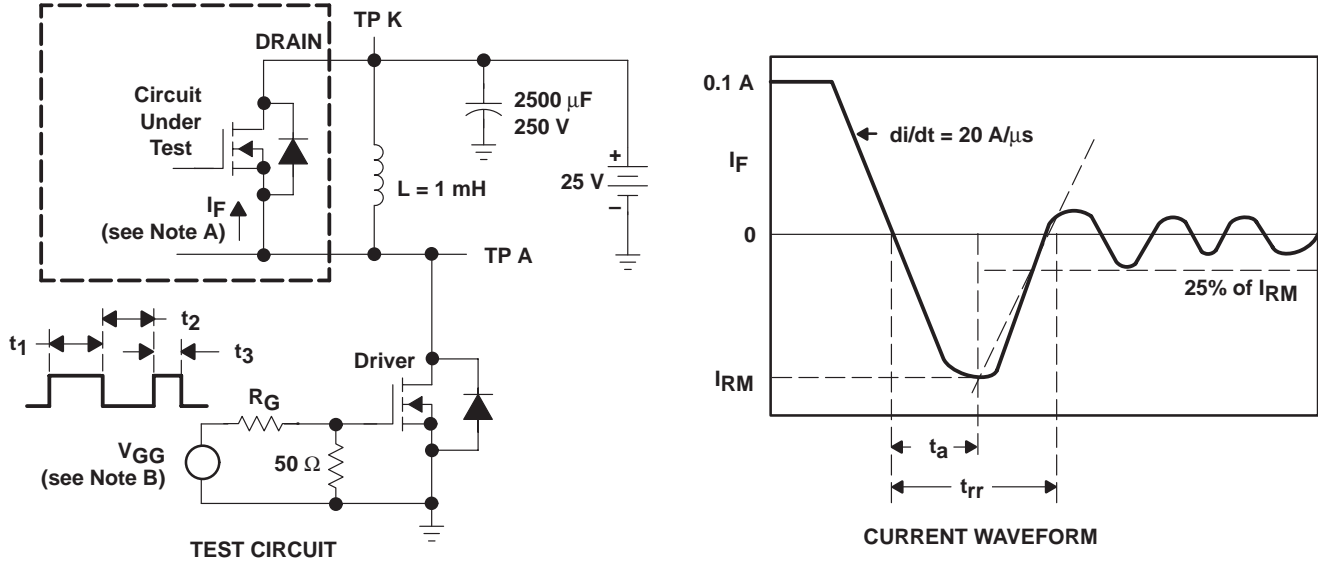
Figure 2. Test Circuit, Switching Times, and Voltage Waveforms

- NOTES: A. The word generator has the following characteristics:  $t_r \leq 10$  ns,  $t_f \leq 10$  ns,  $t_w = 300$  ns, pulsed repetition rate (PRR) = 5 KHz,  $Z_0 = 50$   $\Omega$ .  
 B.  $C_L$  includes probe and jig capacitance.

# TPIC6B273 POWER LOGIC OCTAL D-TYPE LATCH

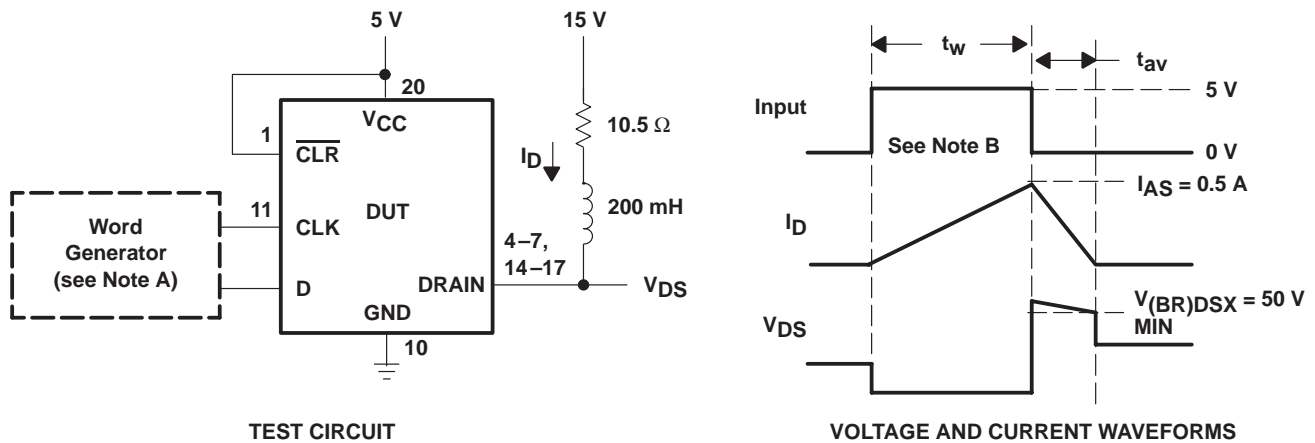
SLIS031 – APRIL 1994 – REVISED JULY 1995

## PARAMETER MEASUREMENT INFORMATION



- NOTES: A. The DRAIN terminal under test is connected to the TP K test point. All other terminals are connected together and connected to the TP A test point.  
 B. The  $V_{GG}$  amplitude and  $R_G$  are adjusted for  $di/dt = 20 \text{ A}/\mu\text{s}$ . A  $V_{GG}$  double-pulse train is used to set  $I_F = 0.1 \text{ A}$ , where  $t_1 = 10 \mu\text{s}$ ,  $t_2 = 7 \mu\text{s}$ , and  $t_3 = 3 \mu\text{s}$ .

Figure 3. Reverse-Recovery-Current Test Circuit and Waveforms of Source-to-Drain Diode



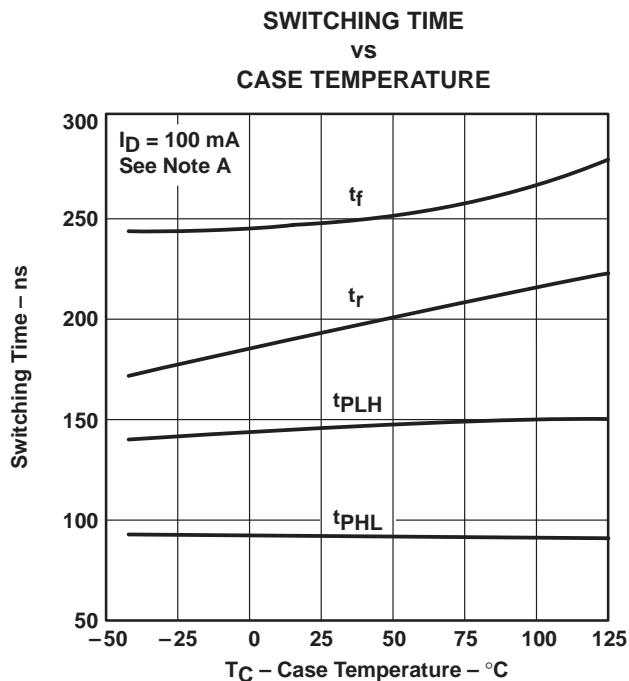
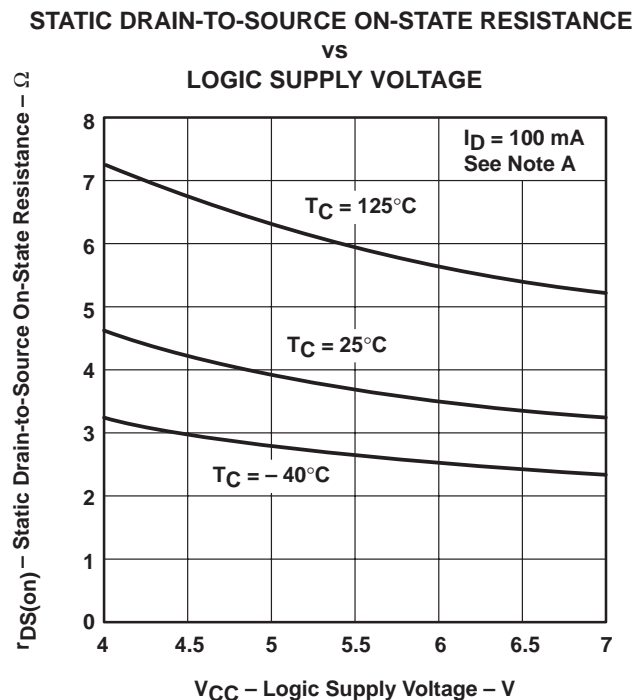
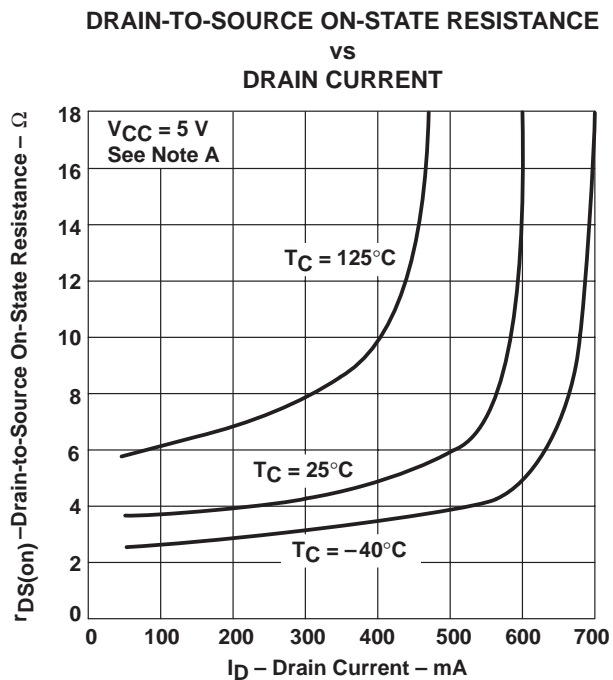
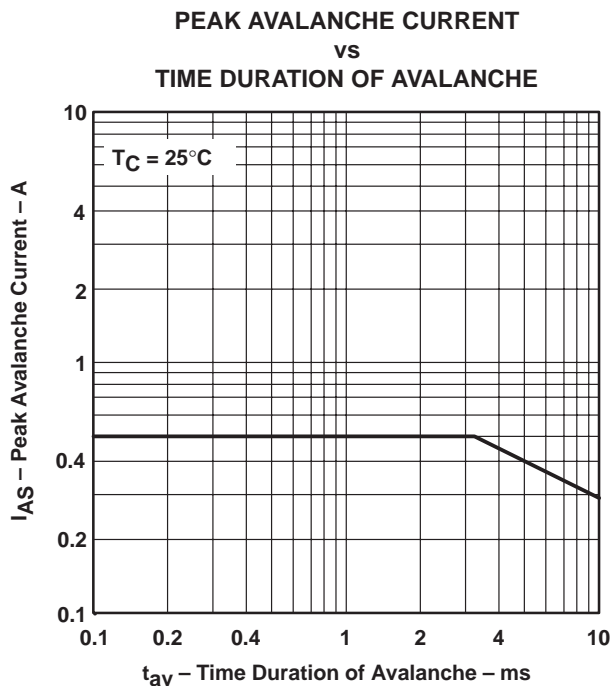
- NOTES: A. The word generator has the following characteristics:  $t_r \leq 10 \text{ ns}$ ,  $t_f \leq 10 \text{ ns}$ ,  $Z_O = 50 \Omega$ .  
 B. Input pulse duration,  $t_w$ , is increased until peak current  $I_{AS} = 0.5 \text{ A}$ .  
 Energy test is defined as  $E_{AS} = I_{AS} \times V_{(BR)DSX} \times t_{av}/2 = 30 \text{ mJ}$ .

Figure 4. Single-Pulse Avalanche Energy Test Circuit and Waveforms

# TPIC6B273 POWER LOGIC OCTAL D-TYPE LATCH

SLIS031 – APRIL 1994 – REVISED JULY 1995

## TYPICAL CHARACTERISTICS



NOTE C: Technique should limit  $T_J - T_C$  to 10°C maximum.

# TPIC6B273 POWER LOGIC OCTAL D-TYPE LATCH

SLIS031 – APRIL 1994 – REVISED JULY 1995

## THERMAL INFORMATION

**MAXIMUM CONTINUOUS  
DRAIN CURRENT OF EACH OUTPUT  
VS  
NUMBER OF OUTPUTS CONDUCTING  
SIMULTANEOUSLY**

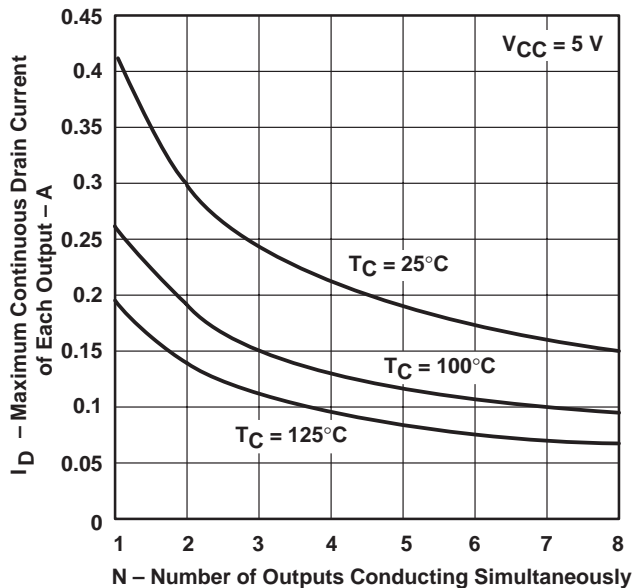


Figure 9

**MAXIMUM PEAK DRAIN CURRENT  
OF EACH OUTPUT  
VS  
NUMBER OF OUTPUTS CONDUCTING  
SIMULTANEOUSLY**

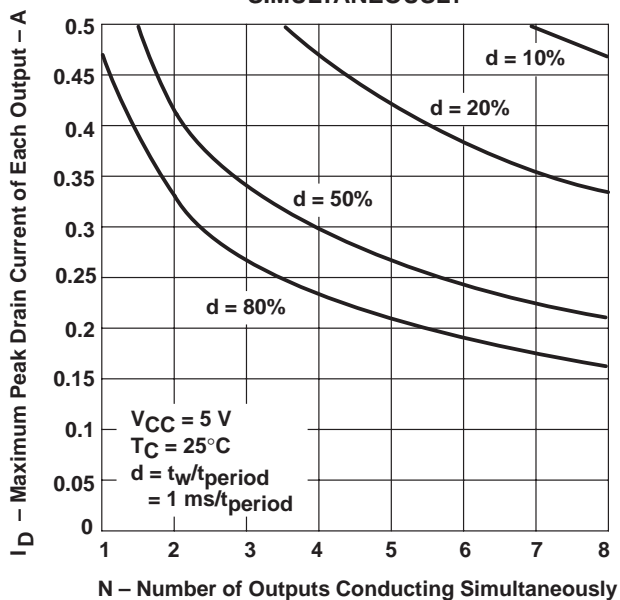


Figure 10



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